



SLD130N04T 40V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

- ☑ PWM Application
- ☑ Load Switch
- ☑ Power Management

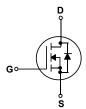
Features

- N-Channel:40V 130A

 $\begin{aligned} R_{DS(on)Typ} &= 2.5 m \Omega @VGS = 10 \text{ V} \\ R_{DS(on)Typ} &= 3.1 m \Omega @VGS = 4.5 \text{ V} \end{aligned}$

- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	•	SLD130N04T	Units
V_{DSS}	Drain-Source Voltage		40	V
1	Drain Current - Continuous (T _C = 25°C)		130	Α
l _D	- Continuous (T _C = 100°C)		84	Α
I_{DM}	Drain Current - Pulsed	(Note 1)	400	Α
V_{GSS}	Gate-Source Voltage		±20	V
Eas	Single Pulsed Avalanche Energy	(Note 2)	250	mJ
P _D	Power Dissipation (T _C = 25°C)		130	W
Rejc	Thermal Resistance, Junction to Case		0.96	°C/W
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purp 1/8" from case for 5 seconds	oses,	300	တ

^{*} Drain current limited by maximum junction temperature.

Max Units

Package Marking

Symbol

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLD130N04T	SLD130N04T	D-PAK	Tape & Reel	2500	25000

Electrical Characteristics

Parameter

T_C = 25°C unless otherwise noted

Test Conditions

Off Characteristics								
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \text{ uA}$	40			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =40 V, V _{GS} = 0 V			1	uA		
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20V, V _{DS} = 0 V			100	nA		
IGSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}$. $V_{DS} = 0 \text{ V}$			-100	nA		

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \text{ uA}$	1.0	1.5	2.3	٧
R _{DS(on)}	Static Drain-Source	V _{GS} =10 V, I _D = 20A	2.5	2.5	3.0	mΩ
	On-Resistance	V _{GS} =4.5 V, I _D = 15A	-	3.1	4.2	11152

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	1	6263	-	pF
Coss	Output Capacitance		1	583	-	pF
C _{rss}	Reverse Transfer Capacitance	1.0 10112		573	-	pF

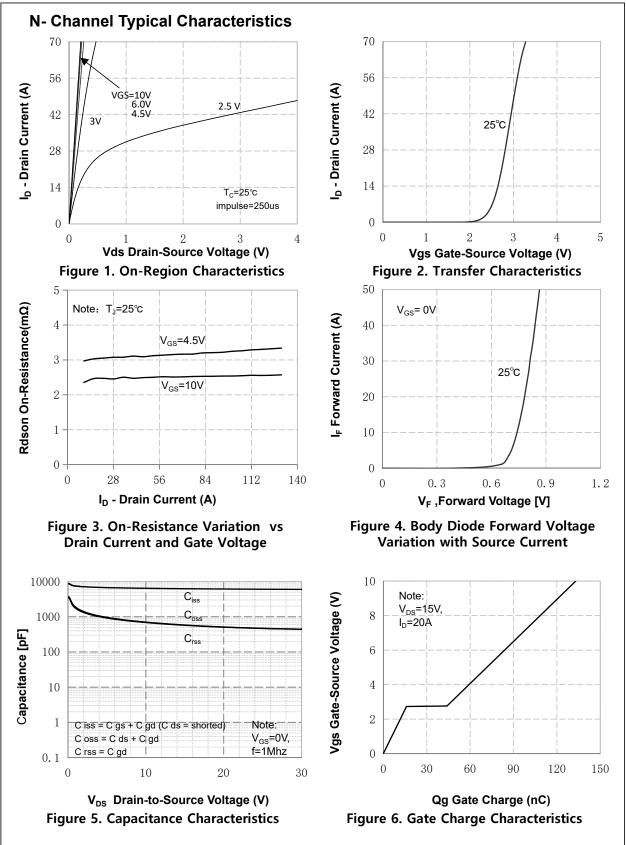
Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time		ı	15		ns
tr	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_L = 3 Ω , I_D =10A Tj=25°C	ı	19	-	ns
$t_{d(off)}$	Turn-Off Delay Time	(Note 3)	-	48		ns
t_f	Turn-Off Fall Time		ı	14	-	ns
Q_g	Total Gate Charge	V _{DS} =15V, I _D =20A,		133		nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10V$, $I_{D} = 20A$, $V_{GS} = 10V$ (Note 3)		29		nC
Q_{gd}	Gate-Drain Charge		ı	16		nC
R _G	Gate Resistance	f = 1MHz	1	1.3	-	Ω

Drain-Source Diode Characteristics and Maximum Ratings

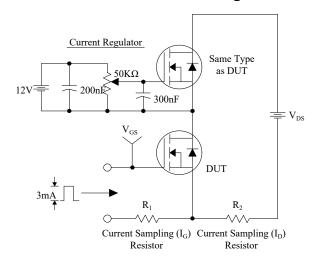
Is	Maximum Continuous Drain-Source Diode Forward Current	-	 130	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		 400	Α
V _{SD}	Drain to Source Diode Forward Voltage, V _{GS} = 0V, I _{SD} = 20A, T _J = 25°C		 1.2	V

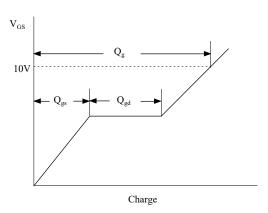
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: T $_{\rm J}$ =25°C, V $_{\rm DD}$ =20V, V $_{\rm G}$ =10V, R $_{\rm G}$ =25 Ω , L=0.5mH. 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



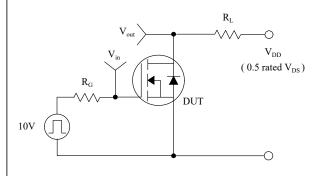
N- Channel Typical Characteristics (Continued) 10 500 Vds Drain-Source Voltage (V) $R_{DS(ON)~(m\Omega)}$ Drain-Source On Resistance 8 400 6 300 4 200 2 100 0 0 2 4 6 8 0 10 2 8 () 6 10 Vgs Gate-Voltage (V) Vds Drain-Source Voltage Vgs Gate-Voltage (V) Figure 8. On-Resistance Figure 7. vs Gate Voltage vs Gate Voltage 150 1000 l_D - Drain Current (A) 120 I D - Drain Current (A) 100 90 Limited by R_{DS(on)} 10ms 10 100ms 60 1 30 Note: T_J=25°C 0 0.1 75 10 25 50 100 125 150 0.1 100 Vds Drain-Source Voltage (V) T_J-Junction Temperature(°C) Figure 9. Maximum Safe Operating Area Figure 10. Maximum Continuous Drain Current vs Temperature 10 In descending order r(t),Normalized Effective Transient Thermal Impedance D=0.5, 0.3, 0.1, 0.05, 0.03, 0.01, Single Pulse 1 0.1 $T_j - T_C = P_{DM} * Z_{\theta j c(t)}$ Duty Factor: D=t1/t2 0.01 0.001 0.00001 0.0001 0.01 0.1 Square Wave Pluse Duration(sec) Figure 11. Transient Thermal Response Curve

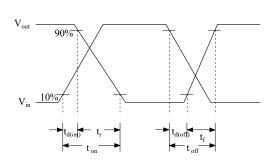
Gate Charge Test Circuit & Waveform



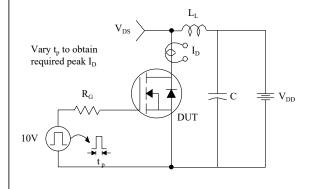


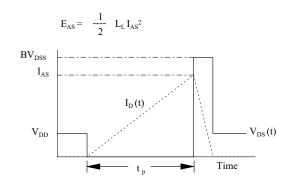
Resistive Switching Test Circuit & Waveforms



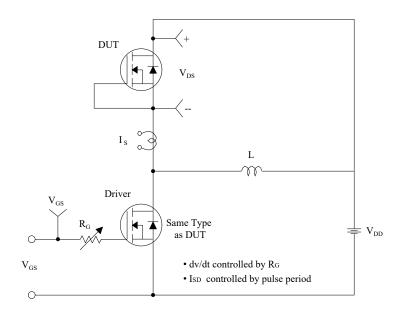


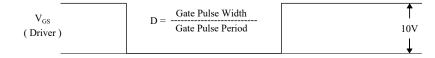
Unclamped Inductive Switching Test Circuit & Waveforms

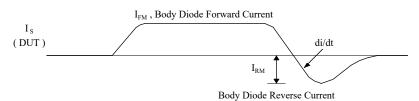


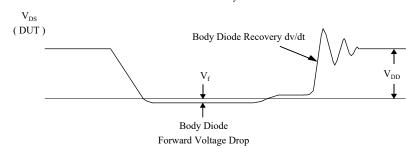


Peak Diode Recovery dv/dt Test Circuit & Waveforms

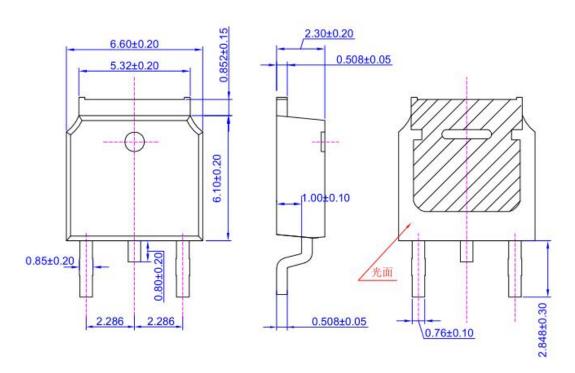


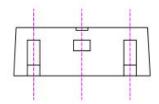






TO-252 OUTLINE





NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8

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